

# FODM8061

## High Noise Immunity, 3.3V/5V, 10Mbit/sec Logic Gate Output (Open Collector) Optocoupler

### Features

- High Noise Immunity characterized by common mode transient immunity (CMTi)
  - 20kV/μs Minimum CMTi
- High Speed
  - 10Mbit/sec Data Rate (NRZ)
  - 80ns max. Propagation Delay
  - 25ns max. Pulse Width Distortion
  - 40ns max. Propagation Delay Skew
- 3.3V LVTTL/LVCMOS Compatibility
- Specifications guaranteed over 3V to 5.5V supply voltage and -40°C to +110°C temperature range
- Safety and regulatory approvals
  - UL1577, 3750 VAC<sub>RMS</sub> for 1 min.
  - IEC60747-5-2 (pending approval)

### Applications

- Microprocessor system interface
  - SPI, I<sup>2</sup>C
- Industrial fieldbus communications
  - DeviceNet, CAN, RS485
- Programmable logic control
- Isolated data acquisition system
- Voltage level translator
- Isolating MOSFET/IGBT gate drivers

### Description

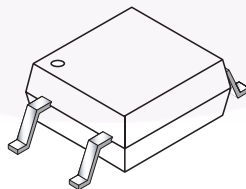
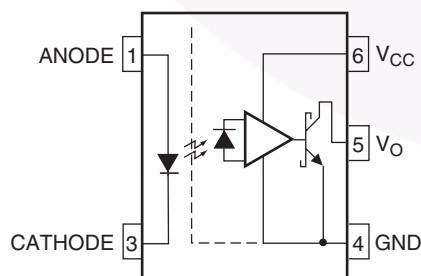
The FODM8061 is a 3.3V/5V high-speed logic gate output (open collector) optocoupler, which supports isolated communications allowing digital signals to communicate between systems without conducting ground loops or hazardous voltages. It utilizes Fairchild's proprietary coplanar packaging technology, Optoplana<sup>®</sup> and optimized IC design to achieve high noise immunity, characterized by high common mode transient immunity specifications.

This optocoupler consists of an AlGaAs LED at the input, optically coupled to a high speed integrated photo-detector logic gate. The output of the detector IC is an open collector schottky-clamped transistor. The coupled parameters are guaranteed over the wide temperature range of -40°C to +110°C. A maximum input signal of 5mA will provide a minimum output sink current of 13mA (fan out of 8).

### Related Resources

- [www.fairchildsemi.com/products/opto/](http://www.fairchildsemi.com/products/opto/)
- [www.fairchildsemi.com/pf/FO/FODM611.html](http://www.fairchildsemi.com/pf/FO/FODM611.html)
- [www.fairchildsemi.com/pf/FO/FODM8071.html](http://www.fairchildsemi.com/pf/FO/FODM8071.html)

### Functional Schematic



### Truth Table

LED	Output
Off	High
On	Low

## Pin Definitions

Number	Name	Function Description
1	ANODE	Anode
3	CATHODE	Cathode
4	GND	Output Ground
5	$V_O$	Output Voltage
6	$V_{CC}$	Output Supply Voltage

## Safety and Insulation Ratings for Mini-Flat Package (SO5 Pin)

As per IEC60747-5-2 (Pending Certification). This optocoupler is suitable for “safe electrical insulation” only within the safety limit data. Compliance with the safety ratings shall be ensured by means of protective circuits.

Symbol	Parameter	Min.	Typ.	Max.	Unit
	Installation Classifications per DIN VDE 0110/1.89 Table 1				
	For rated main voltage < 150Vrms		I-IV		
	For rated main voltage < 300Vrms		I-III		
	Climatic Classification		40/110/21		
	Pollution Degree (DIN VDE 0110/1.89)		2		
CTI	Comparative Tracking Index	175			
$V_{PR}$	Input to Output Test Voltage, Method b, $V_{IORM} \times 1.875 = V_{PR}$ , 100% Production Test with $t_m = 1$ sec, Partial Discharge < 5 pC	1060			
$V_{PR}$	Input to Output Test Voltage, Method a, $V_{IORM} \times 1.5 = V_{PR}$ , Type and Sample Test with $t_m = 60$ sec, Partial Discharge < 5 pC	848			
$V_{IORM}$	Max Working Insulation Voltage	565			$V_{peak}$
$V_{IOTM}$	Highest Allowable Over Voltage	4000			$V_{peak}$
	External Creepage	5.0			mm
	External Clearance	5.0			mm
	Insulation thickness	0.5			mm
$T_{Case}$	Safety Limit Values, Maximum Values allowed in the event of a failure, Case Temperature	150			°C
$R_{IO}$	Insulation Resistance at $T_S$ , $V_{IO} = 500V$	$10^9$			$\Omega$

**Absolute Maximum Ratings** ( $T_A=25^{\circ}\text{C}$  unless otherwise specified)

Stresses exceeding the absolute maximum ratings may damage the device. The device may not function or be operable above the recommended operating conditions and stressing the parts to these levels is not recommended. In addition, extended exposure to stresses above the recommended operating conditions may affect device reliability. The absolute maximum ratings are stress ratings only.

Symbol	Parameter	Value	Units
$T_{\text{STG}}$	Storage Temperature	-40 to +125	$^{\circ}\text{C}$
$T_{\text{OPR}}$	Operating Temperature	-40 to +110	$^{\circ}\text{C}$
$T_J$	Junction Temperature	-40 to +125	$^{\circ}\text{C}$
$T_{\text{SOL}}$	Lead Solder Temperature (Refer to Reflow Temperature Profile)	260 for 10sec	$^{\circ}\text{C}$
$I_F$	Forward Current	50	mA
$V_R$	Reverse Voltage	5.0	V
$V_{\text{CC}}$	Supply Voltage	0 to 7.0	V
$V_O$	Output Voltage	-0.5 to $V_{\text{CC}}+0.5$	V
$I_O$	Average Output Current	50	mA
$\text{PD}_I$	Input Power Dissipation <sup>(1)(2)</sup>	100	mW
$\text{PD}_O$	Output Power Dissipation <sup>(1)(2)</sup>	85	mW

**Recommended Operating Conditions**

The Recommended Operating Conditions table defines the conditions for actual device operation. Recommended operating conditions are specified to ensure optimal performance to the datasheet specifications. Fairchild does not recommend exceeding them or designing to Absolute Maximum Ratings.

Symbol	Parameter	Min.	Max.	Unit
$T_A$	Ambient Operating Temperature	-40	+110	$^{\circ}\text{C}$
$V_{\text{CC}}, V_{\text{DD}}$	Supply Voltages <sup>(3)</sup>	3.0	5.5	V
$V_{\text{FL}}$	Logic Low Input Voltage	0	0.8	V
$I_{\text{FH}}$	Logic High Input Current <sup>(4)</sup>	6.3	15	mA
$I_{\text{FL}}$	Logic Low Input Current		250	$\mu\text{A}$
N	Fan Out (at $R_L = 1\text{k}\Omega$ )		5	TTL Loads
$R_L$	Output Pull-up Resistor	330	4k	$\Omega$

**Isolation Characteristics** ( $T_A=25^{\circ}\text{C}$ )

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Units
$V_{\text{ISO}}$	Input-Output Isolation Voltage	freq= 60Hz, $t = 1.0\text{min}$ , $I_{\text{I-O}} \leq 10\mu\text{A}^{(5)(6)}$	3750			$\text{VAC}_{\text{RMS}}$
$R_{\text{ISO}}$	Isolation Resistance	$V_{\text{I-O}} = 500\text{V}^{(5)}$		$10^{12}$		$\Omega$
$C_{\text{ISO}}$	Isolation Capacitance	$V_{\text{I-O}} = 0\text{V}$ , freq=1.0MHz <sup>(5)</sup>		0.6		pF

**Notes:**

1. No derate required to  $110^{\circ}\text{C}$ .
2. Functional operation under these conditions is not implied. Permanent damage may occur if the device is subjected to conditions outside these ratings.
3. 0.1 $\mu\text{F}$  bypass capacitor must be connected between pins 4 and 6.
4. Recommended  $I_{\text{FH}}$  is 9.3mA for operation above  $T_A = 100^{\circ}\text{C}$ .
5. Device is considered a two terminal device: Pins 1 and 3 are shorted, and Pins 4, 5, and 6 are shorted together.
6. 3,750  $\text{VAC}_{\text{RMS}}$  for 1 minute duration is equivalent to 4,500  $\text{VAC}_{\text{RMS}}$  for 1 second duration.

**Electrical Characteristics** (Apply over all recommended conditions)(T<sub>A</sub> = -40°C to +110°C, 3.0V ≤ V<sub>CC</sub> ≤ 5.5V), unless otherwise specified.Typical value is measured at T<sub>A</sub> = 25°C and V<sub>CC</sub> = 3.3V.

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Units
INPUT CHARACTERISTICS						
V <sub>F</sub>	Forward Voltage	I <sub>F</sub> = 10mA, Fig. 1	1.05	1.45	1.8	V
BV <sub>R</sub>	Input Reverse Breakdown Voltage	I <sub>R</sub> = 10μA	5.0			V
I <sub>FHL</sub>	Threshold Input Current	V <sub>O</sub> = 0.6V, I <sub>OL</sub> (sinking) = 13mA, T <sub>A</sub> < 85°C, Fig. 2		3.4	5.0	mA
		T <sub>A</sub> = 85°C to 110 °C		4.2	7.5	
OUTPUT CHARACTERISTICS						
V <sub>OL</sub>	Logic LOW Output Voltage	I <sub>F</sub> = rated I <sub>FHL</sub> , I <sub>OL</sub> (sinking) = 13mA, Fig.3		0.4	0.6	V
I <sub>OH</sub>	Logic HIGH Output Current	I <sub>F</sub> = 250μA, V <sub>O</sub> = 3.3V, Fig. 4		8.0	50.0	μA
		I <sub>F</sub> = 250μA, V <sub>O</sub> = 5.0V, Fig. 4		2.1	30.0	μA
I <sub>CCL</sub>	Logic LOW Output Supply Current	I <sub>F</sub> = 10mA, V <sub>CC</sub> = 3.3V, Fig. 5, 7		6.0	8.5	mA
		I <sub>F</sub> = 10mA, V <sub>CC</sub> = 5.0V, Fig. 5, 7		7.5	10.0	mA
I <sub>CCH</sub>	Logic HIGH Output Supply Current	I <sub>F</sub> = 0mA, V <sub>CC</sub> = 3.3V, Fig. 6, 7		4.0	7.0	mA
		I <sub>F</sub> = 0mA, V <sub>CC</sub> = 5.0V, Fig. 6, 7		6.0	9.0	mA

**Switching Characteristics** (Apply over all recommended conditions)(T<sub>A</sub> = -40°C to +110°C, 3.0V ≤ V<sub>CC</sub> ≤ 5.5V, I<sub>F</sub> = 7.5mA), unless otherwise specified.Typical value is measured at T<sub>A</sub> = 25°C and V<sub>CC</sub> = 3.3V

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Units
Date Rate		R <sub>L</sub> = 350Ω			10	Mbps
t <sub>PHL</sub>	Propagation Delay Time to Logic Low Output	R <sub>L</sub> = 350Ω, C <sub>L</sub> = 15pF, Fig. 8 and 11		43	80	ns
t <sub>PLH</sub>	Propagation Delay Time to Logic High Output	R <sub>L</sub> = 350Ω, C <sub>L</sub> = 15pF, Fig. 8 and 11		50	80	ns
PWD	Pulse Width Distortion,  t <sub>PHL</sub> - t <sub>PLH</sub>	R <sub>L</sub> = 350Ω, C <sub>L</sub> = 15pF, Fig. 9		7	25	ns
t <sub>PSK</sub>	Propagation Delay Skew	R <sub>L</sub> = 350Ω, C <sub>L</sub> = 15pF <sup>(7)</sup>			40	ns
t <sub>R</sub>	Output Rise Time, (10% to 90%)	R <sub>L</sub> = 350Ω, C <sub>L</sub> = 15pF, Fig. 10 and 11		20		ns
t <sub>F</sub>	Output Fall Time, (90% to 10%)	R <sub>L</sub> = 350Ω, C <sub>L</sub> = 15pF, Fig. 10 and 11		10		ns
CM <sub>H</sub>	Common Mode Transient Immunity at Output High	I <sub>F</sub> = 0mA, V <sub>O</sub> > 0.8 × V <sub>CC</sub> , V <sub>CM</sub> = 1000V <sup>(8)</sup> , Fig. 12	20	40		kV/μs
CM <sub>L</sub>	Common Mode Transient Immunity at Output Low	I <sub>F</sub> = 7.5mA, V <sub>O</sub> < 0.8V, V <sub>CM</sub> = 1000V <sup>(8)</sup> , Fig. 12	20	40		kV/μs

**Notes**

- t<sub>PSK</sub> is equal to the magnitude of the worst case difference in t<sub>PHL</sub> and/or t<sub>PLH</sub> that will be seen between any two units from the same manufacturing date code that are operated at same case temperature (±5°C), at same operating conditions, with equal loads (R<sub>L</sub> = 350Ω and C<sub>L</sub> = 15pF), and with an input rise time less than 5ns.
- Common mode transient immunity at output high is the maximum tolerable positive dV<sub>cm</sub>/dt on the leading edge of the common mode impulse signal, V<sub>cm</sub>, to assure that the output will remain high. Common mode transient immunity at output low is the maximum tolerable negative dV<sub>cm</sub>/dt on the trailing edge of the common pulse signal, V<sub>cm</sub>, to assure that the output will remain low.

## Typical Performance Curves

Fig. 1 Input LED Current vs Forward Voltage

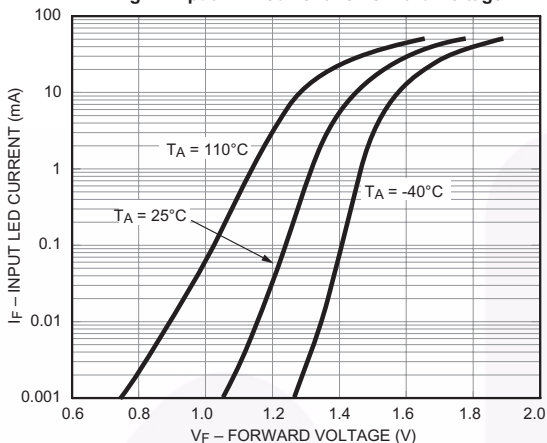


Fig. 2 Threshold Input Current vs Ambient Temperature

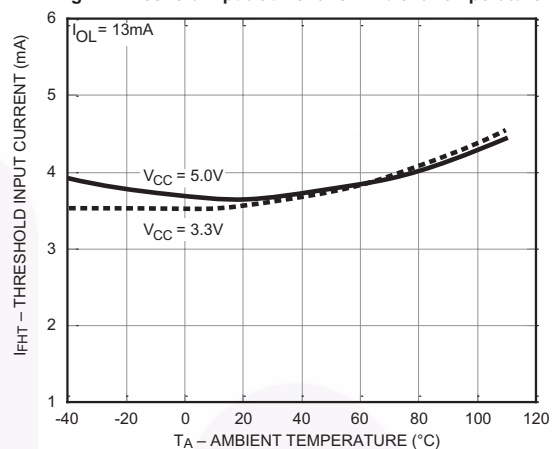


Fig. 3 Low Level Output Voltage vs. Ambient Temperature

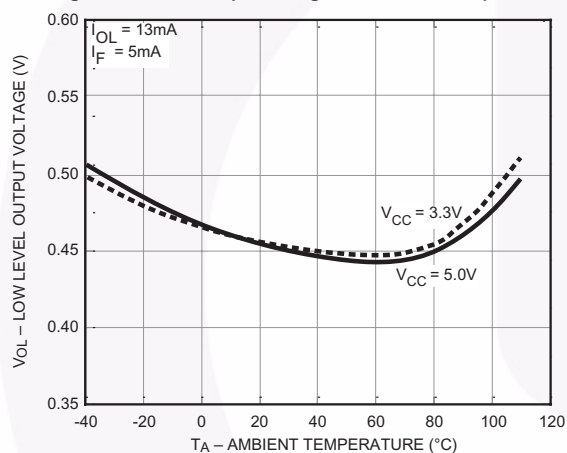


Fig. 4 Logic High Output Current vs Ambient Temperature

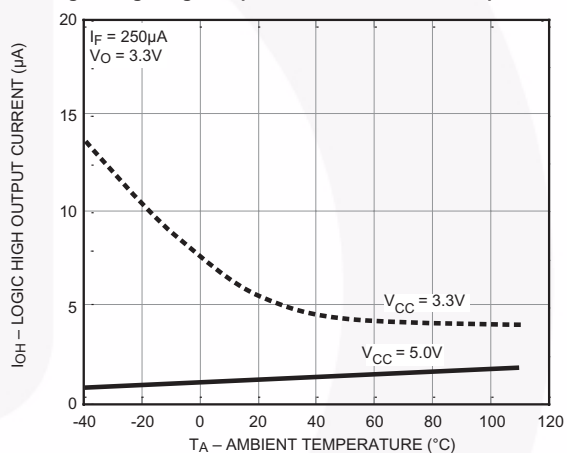


Fig. 5 Typical Logic Low Output Supply Current vs. Ambient Temperature

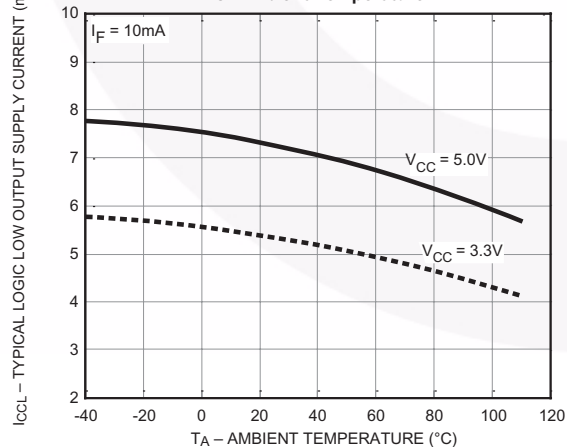
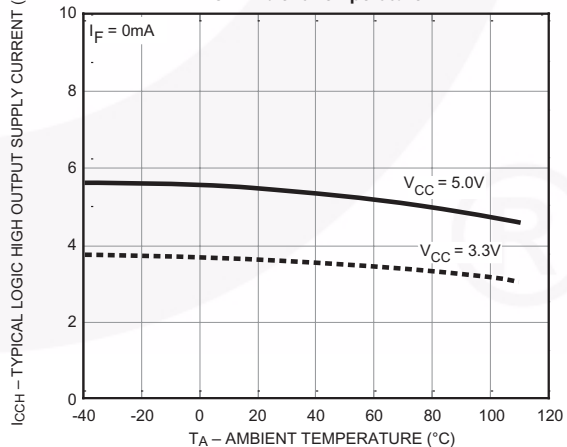
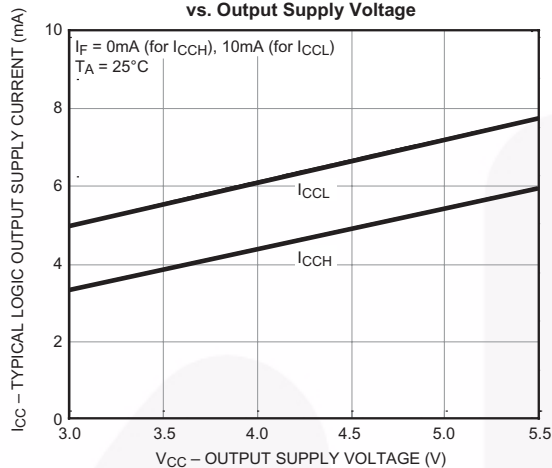


Fig. 6 Typical Logic High Output Supply Current vs. Ambient Temperature

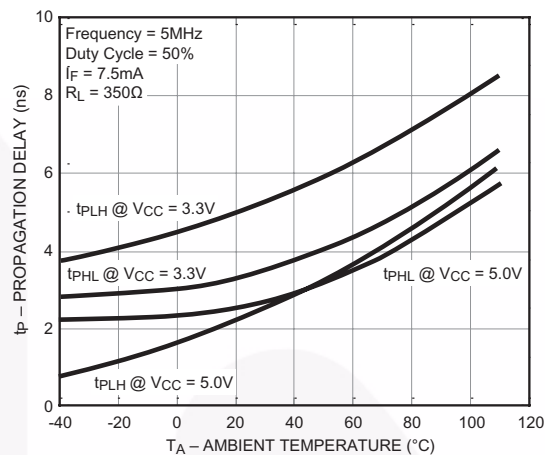


## Typical Performance Curves (Continued)

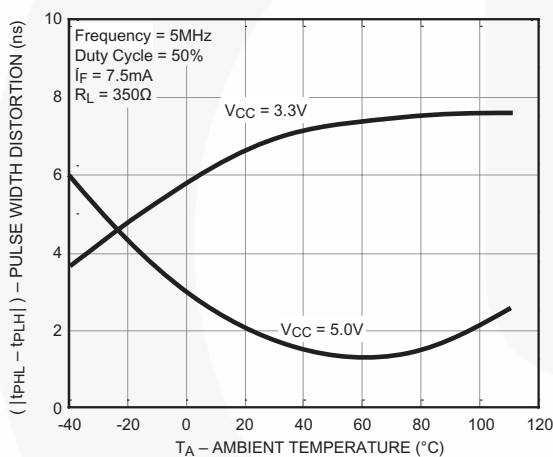
**Fig. 7 Typical Logic Output Supply Current vs. Output Supply Voltage**



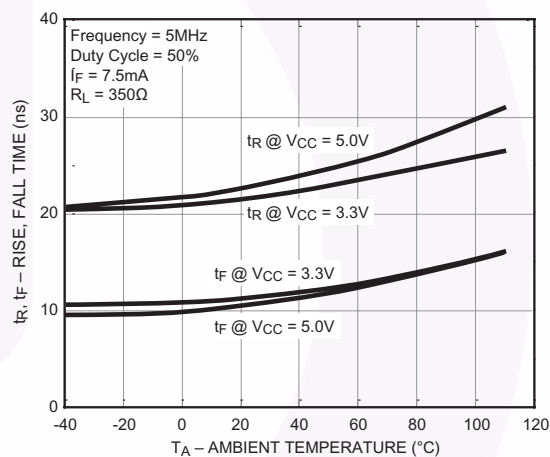
**Fig. 8 Typical Propagation Delay vs. Ambient Temperature**



**Fig. 9 Typical Pulse Width Distortion vs. Ambient Temperature**



**Fig. 10 Typical Rise and Fall Time vs. Ambient Temperature**



## Schematics

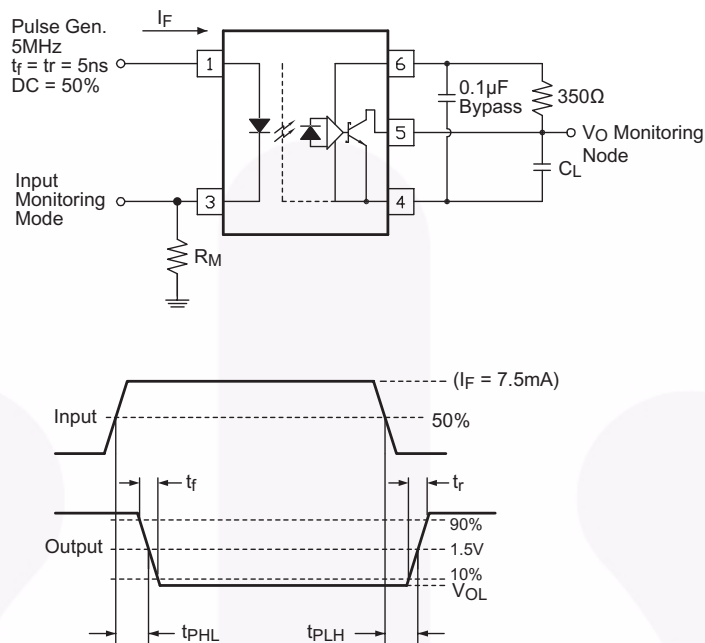


Figure 11. Test Circuit for Propagation Delay Time, Rise Time and Fall Time

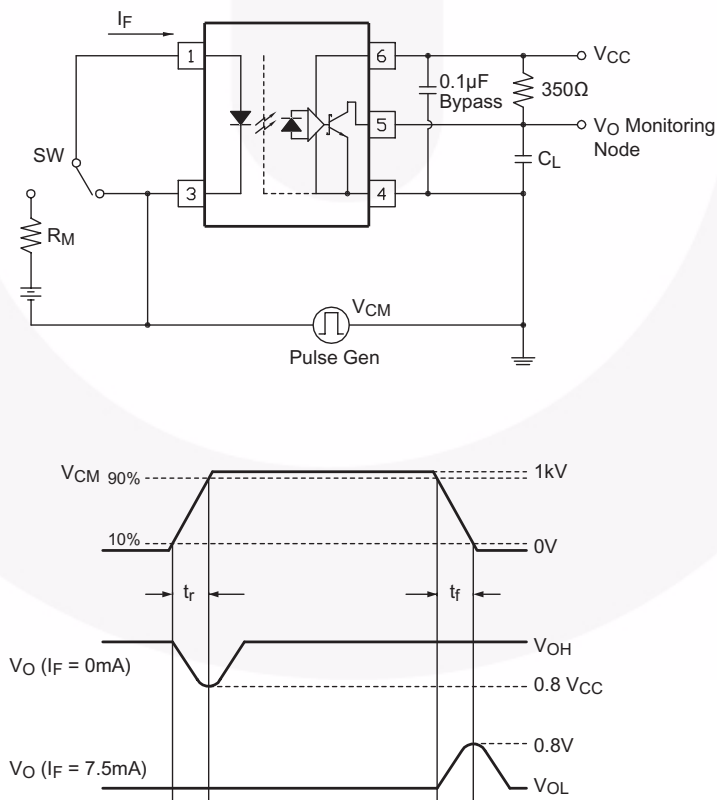
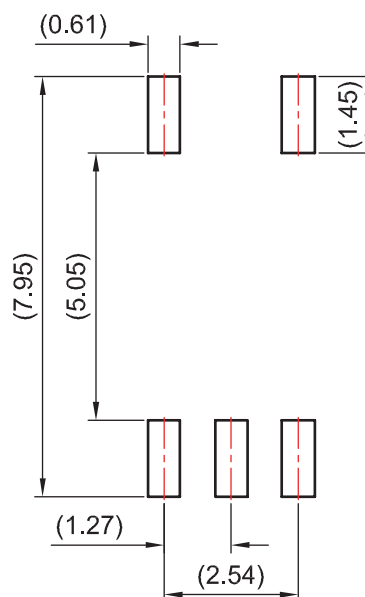
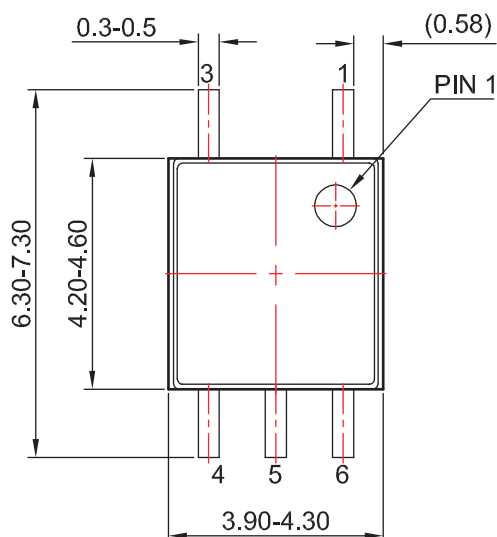
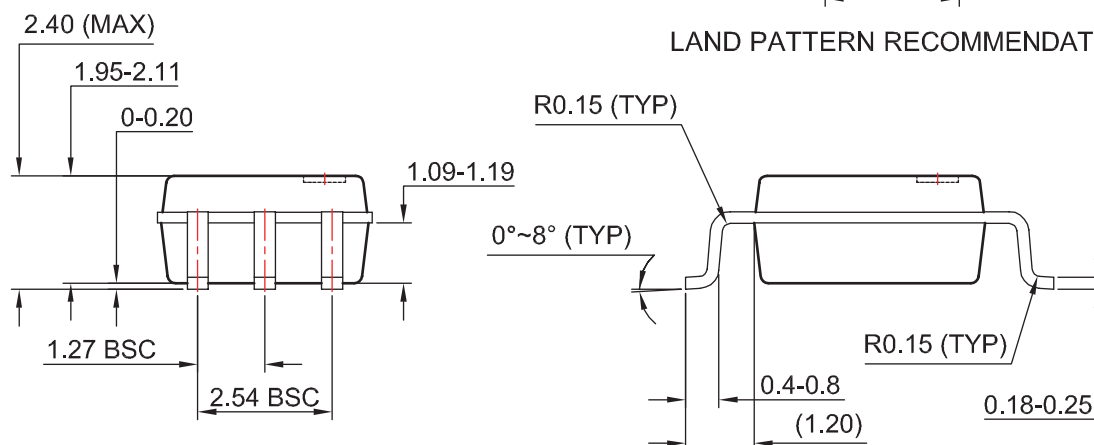


Figure 12. Test Circuit for Instantaneous Common Mode Rejection Voltage

## Package Dimensions



## LAND PATTERN RECOMMENDATION



### Notes:

1. No standard applies to this package.
2. All dimensions are in millimeters.
3. Dimensions are exclusive of burrs, mold flash, and tie bar extrusion.
4. Drawings filename and revision: MKT-MFP05A.

Package drawings are provided as a service to customers considering Fairchild components. Drawings may change in any manner without notice. Please note the revision and/or date on the drawing and contact a Fairchild Semiconductor representative to verify or obtain the most recent revision. Package specifications do not expand the terms of Fairchild's worldwide terms and conditions, specifically the warranty therein, which covers Fairchild products.

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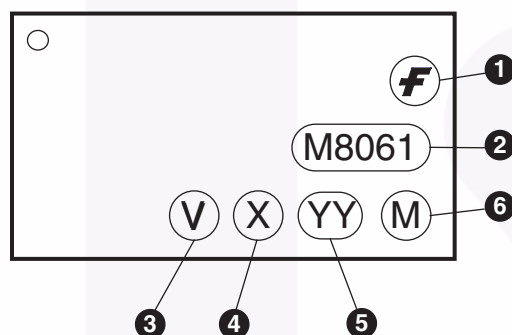
## Ordering Information

Option	Order Entry Identifier (Example)	Description
No Suffix	FODM8061	Mini-Flat 5-pin, shipped in tubes (100 units per tube)
R2	FODM8061R2	Mini-Flat 5-pin, tape and reel (2,500 units per reel)



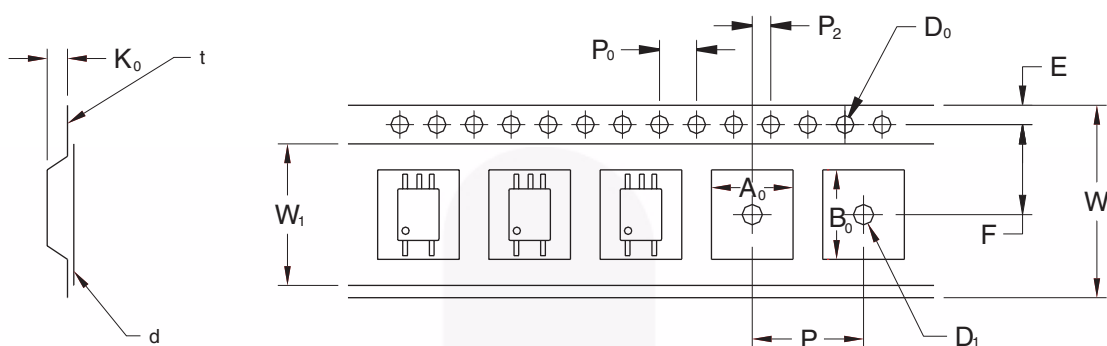
All packages are lead free per JEDEC: J-STD-020B standard.

## Marking Information



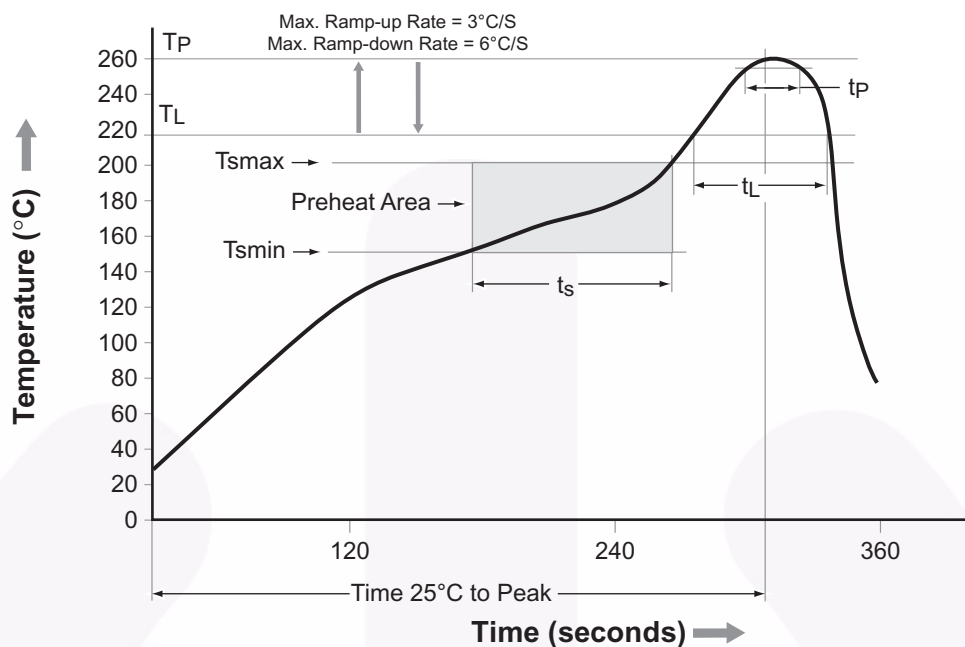
Definitions	
1	Fairchild logo
2	Device number
3	IEC60747-5-2 (VDE marking)
4	One digit year code, e.g., '9'
5	Two digit work week ranging from '01' to '53'
6	Assembly package code

## Tape and Reel Dimensions



		2.54 Pitch
Description	Symbol	Dimensions (mm)
Tape Width	W	12.00 +0.30/-0.10
Tape Thickness	t	0.30 ±0.05
Sprocket Hole Pitch	P <sub>0</sub>	4.00 ±0.10
Sprocket Hole Diameter	D <sub>0</sub>	1.50 +0.10/-0.0
Sprocket Hole Location	E	1.75 ±0.10
Pocket Location	F	5.50 ±0.10
	P <sub>2</sub>	2.00 ±0.10
Pocket Pitch	P	8.00 ±0.10
Pocket Dimension	A <sub>0</sub>	4.40 ±0.10
	B <sub>0</sub>	7.30 ±0.10
	K <sub>0</sub>	2.30 ±0.10
Pocket Hole Diameter	D <sub>1</sub>	1.50 Min.
Cover Tape Width	W <sub>1</sub>	9.20
Cover Tape Thickness	d	0.065 ±0.010
Max. Component Rotation or Tilt		10° Max.
Devices Per Reel		2500
Reel Diameter		330mm (13")

## Reflow Profile



Profile Feature	Pb-Free Assembly Profile
Temperature Min. (Tsmin)	150°C
Temperature Max. (Tsmax)	200°C
Time (ts) from (Tsmin to Tsmax)	60–120 seconds
Ramp-up Rate (tL to tp)	3°C/second max.
Liquidous Temperature (TL)	217°C
Time (tL) Maintained Above (TL)	60–150 seconds
Peak Body Package Temperature	260°C +0°C / -5°C
Time (tp) within 5°C of 260°C	30 seconds
Ramp-down Rate (TP to TL)	6°C/second max.
Time 25°C to Peak Temperature	8 minutes max.



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EfficientMax™  
ESBC™  
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FAST®  
FastvCore™  
FETBench™  
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FPS™

F-PFS™  
FRFET®  
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Green FPS™  
Green FPS™ e-Series™  
Gmax™  
GTO™  
IntelliMAX™  
ISOPLANAR™  
MegaBuck™  
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SuperSOT™-6  
SuperSOT™-8  
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the power franchise  
TinyBoost™  
TinyBuck™  
TinyCalc™  
TinyLogic®  
TINYOPTO™  
TinyPower™  
TinyPWM™  
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2. A critical component in any component of a life support, device, or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

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### Definition of Terms

Datasheet Identification	Product Status	Definition
Advance Information	Formative / In Design	Datasheet contains the design specifications for product development. Specifications may change in any manner without notice.
Preliminary	First Production	Datasheet contains preliminary data; supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve design.
No Identification Needed	Full Production	Datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve the design.
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